

Search Notes

Application/Control No.

10/816,860

Examiner

Richale L. Haney

Applicant(s)/Patent under
Reexamination

SHIN, SUNG SU

Art Unit

3765

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Updated	1/11/2004	RLH